



## Description

### JMG N-channel Advanced Mode Power MOSFET

#### Features

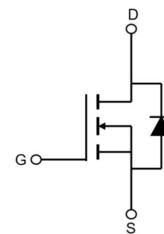
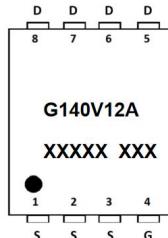
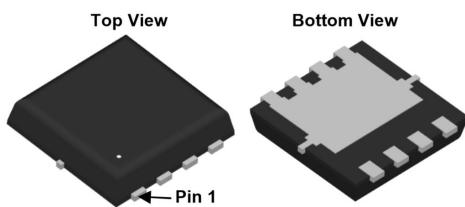
- 120V,50A
- $R_{DS(ON)} < 13.8m\Omega$  @  $V_{GS} = 10V$
- Advanced Split Gate Trench Technology
- Excellent  $R_{DS(ON)}$  and Low Gate Charge
- Lead Free

#### Application

- Load Switch
- PWM Application
- Power Management



100% UIS TESTED!  
100%  $\Delta V_{ds}$  TESTED!



PDFN5x6-8L

Marking and pin Assignment

Schematic Diagram

## Package Marking and Ordering Information

| Device Marking | Device      | Outline | Package    | Reel Size | Reel (pcs) | Per Carton (pcs) |
|----------------|-------------|---------|------------|-----------|------------|------------------|
| G140V12A       | JMGG140V12A | TAPING  | PDFN5x6-8L | 13"       | 2500       | 25000            |

## Absolute Maximum Ratings ( $T_C=25^\circ C$ unless otherwise specified)

| Symbol          | Parameter                                       |                     | Max.        | Units        |
|-----------------|---|---------------------|-------------|--------------|
| $V_{DSS}$       | Drain-Source Voltage                            |                     | 120         | V            |
| $V_{GSS}$       | Gate-Source Voltage                             |                     | $\pm 25$    | V            |
| $I_D$           | Continuous Drain Current                        | $T_C = 25^\circ C$  | 50          | A            |
|                 |   | $T_C = 100^\circ C$ | 33          | A            |
| $I_{DM}$        | Pulsed Drain Current <sup>note1</sup>           |                     | 200         | A            |
| $E_{AS}$        | Single Pulsed Avalanche Energy <sup>note2</sup> |                     | 81          | mJ           |
| $P_D$           | Power Dissipation                               | $T_C = 25^\circ C$  | 60          | W            |
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case            |                     | 2.1         | $^\circ C/W$ |
| $T_J, T_{STG}$  | Operating and Storage Temperature Range         |                     | -55 to +150 | $^\circ C$   |

**Electrical Characteristics** ( $T_J=25^\circ\text{C}$  unless otherwise specified)

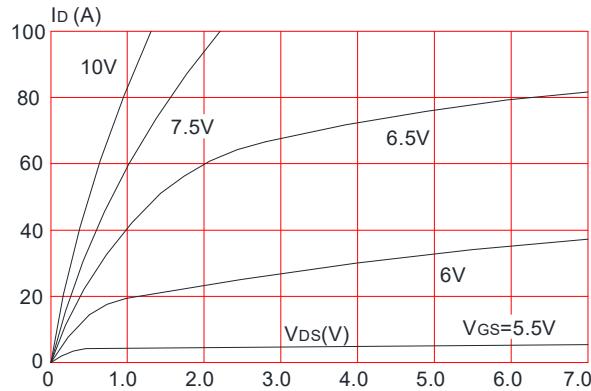
| Symbol  | Parameter  | Test Condition   | Min. | Typ. | Max.      | Units            |
|---|--|--|------|------|-----------|------------------|
| <b>Off Characteristics</b>                                    |  |  |      |      |           |                  |
| $V_{(\text{BR})\text{DSS}}$                                   | Drain-Source Breakdown Voltage                           | $V_{GS}=0\text{V}$ , $I_D=250\mu\text{A}$  | 120  | -    | -         | V                |
| $I_{DSS}$   | Zero Gate Voltage Drain Current                          | $V_{DS}=120\text{V}$ , $V_{GS}=0\text{V}$ ,  | -    | -    | 1.0       | $\mu\text{A}$    |
| $I_{GSS}$   | Gate to Body Leakage Current                             | $V_{DS}=0\text{V}$ , $V_{GS}= \pm 25\text{V}$  | -    | -    | $\pm 100$ | nA               |
| <b>On Characteristics</b>                                     |  |  |      |      |           |                  |
| $V_{GS(\text{th})}$   | Gate Threshold Voltage                                   | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$   | 2    | -    | 4         | V                |
| $R_{DS(\text{on})}$   | Static Drain-Source on-Resistance<br>note3               | $V_{GS}=10\text{V}$ , $I_D=20\text{A}$   | -    | 11   | 13.8      | $\text{m}\Omega$ |
| <b>Dynamic Characteristics</b>                                |  |  |      |      |           |                  |
| $C_{iss}$   | Input Capacitance  | $V_{DS}=25\text{V}$ , $V_{GS}=0\text{V}$ ,<br>$f=1.0\text{MHz}$                            | -    | 1625 | -         | pF               |
| $C_{oss}$   | Output Capacitance                                       |  | -    | 1230 | -         | pF               |
| $C_{rss}$   | Reverse Transfer Capacitance                             |  | -    | 29   | -         | pF               |
| $Q_g$   | Total Gate Charge  | $V_{DD}=60\text{V}$ , $I_D=20\text{A}$ ,<br>$V_{GS}=10\text{V}$                            | -    | 37   | -         | nC               |
| $Q_{gs}$  | Gate-Source Charge                                       |  | -    | 14   | -         | nC               |
| $Q_{gd}$  | Gate-Drain("Miller") Charge                              |  | -    | 8    | -         | nC               |
| <b>Switching Characteristics</b>                              |  |  |      |      |           |                  |
| $t_{d(on)}$   | Turn-on Delay Time                                       | $V_{DD}=50\text{V}$ , $I_D=20\text{A}$ ,<br>$R_{\text{GEN}}=3\Omega$ , $V_{GS}=10\text{V}$ | -    | 11   | -         | ns               |
| $t_r$   | Turn-on Rise Time  |  | -    | 7.5  | -         | ns               |
| $t_{d(off)}$  | Turn-off Delay Time                                      |  | -    | 26   | -         | ns               |
| $t_f$   | Turn-off Fall Time                                       |  | -    | 4    | -         | ns               |
| <b>Drain-Source Diode Characteristics and Maximum Ratings</b> |  |  |      |      |           |                  |
| $I_s$   | Maximum Continuous Drain to Source Diode Forward Current | -  | -    | 50   | -         | A                |
| $I_{SM}$  | Maximum Pulsed Drain to Source Diode Forward Current     | -  | -    | 200  | -         | A                |
| $V_{SD}$  | Drain to Source Diode Forward Voltage                    | $V_{GS}=0\text{V}$ , $I_s=30\text{A}$  | -    | -    | 1.2       | V                |
| $t_{rr}$  | Body Diode Reverse Recovery Time                         | $I_F=30\text{A}$ ,<br>$di/dt=100\text{A}/\mu\text{s}$                                      | -    | 58   | -         | ns               |
| $Q_{rr}$  | Body Diode Reverse Recovery Charge                       |  | -    | 149  | -         | nC               |

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

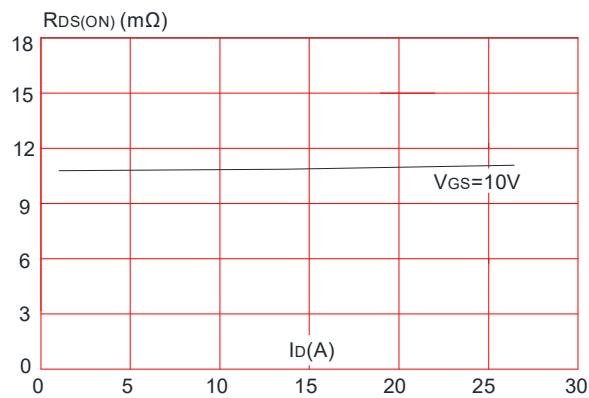
2. EAS condition: Starting  $T_J=25^\circ\text{C}$ ,  $V_{DD}=60\text{V}$ ,  $V_{GS}=10\text{V}$ ,  $R_g=25\Omega$ ,  $L=0.5\text{mH}$ ,  $I_{AS}=18\text{A}$ 3. Pulse Test: Pulse Width $\leq 300\mu\text{s}$ , Duty Cycle $\leq 0.5\%$

## Typical Performance Characteristics

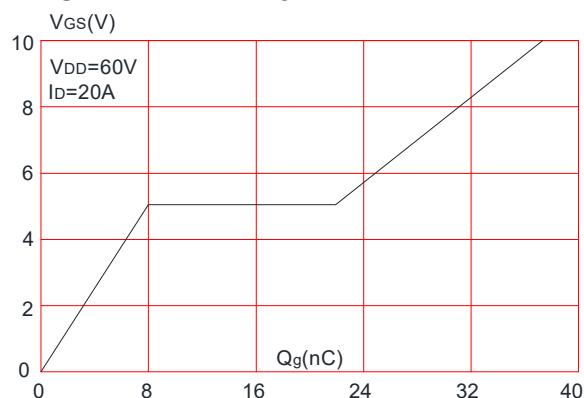
**Figure 1:** Output Characteristics



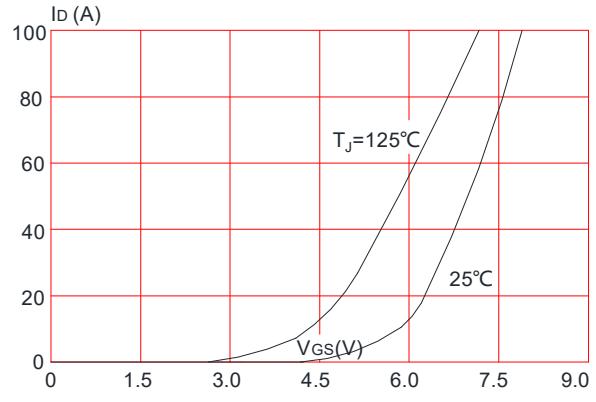
**Figure 3:** On-resistance vs. Drain Current



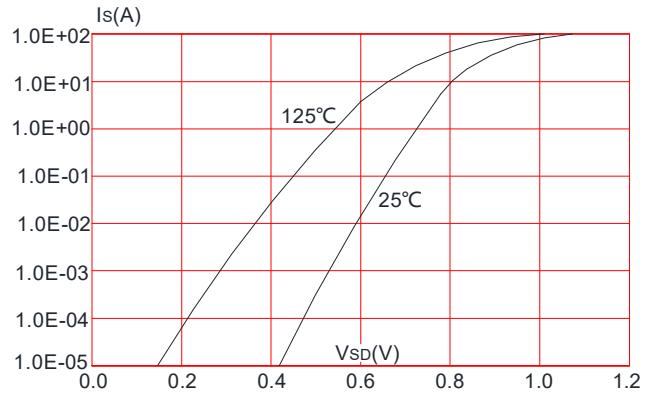
**Figure 5:** Gate Charge Characteristics



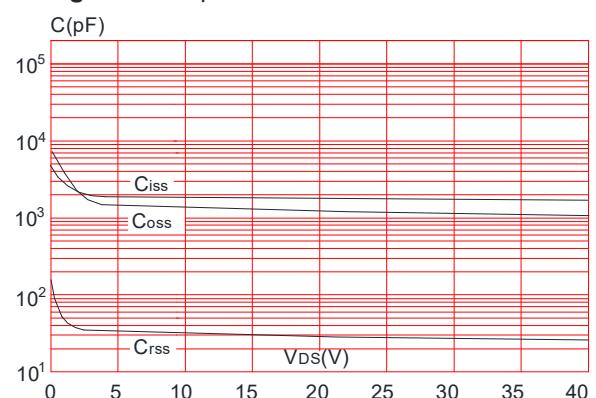
**Figure 2:** Typical Transfer Characteristics



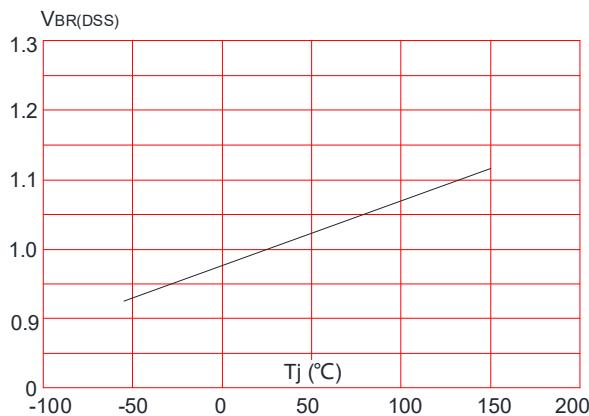
**Figure 4:** Body Diode Characteristics



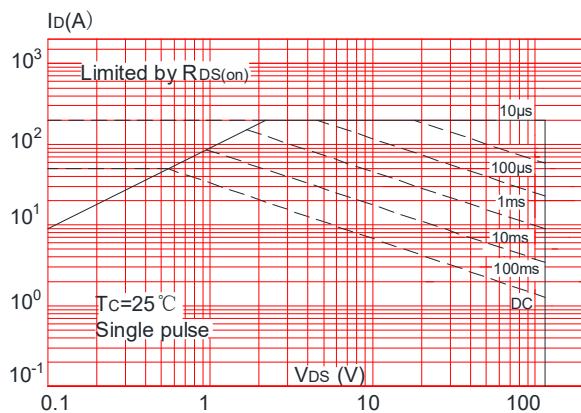
**Figure 6:** Capacitance Characteristics



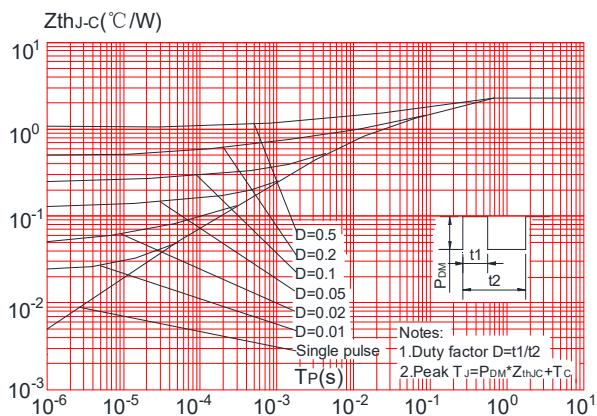
**Figure 7:** Normalized Breakdown Voltage vs. Junction Temperature



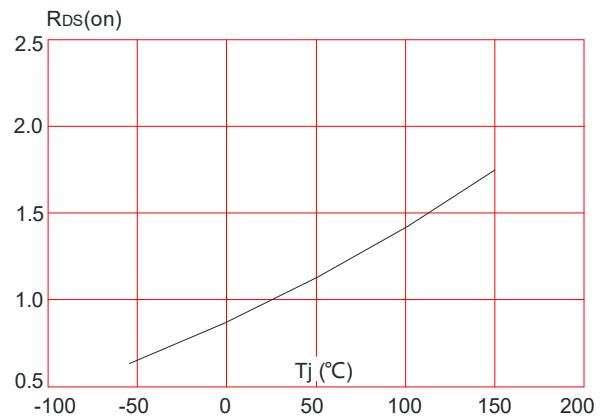
**Figure 9:** Maximum Safe Operating Area



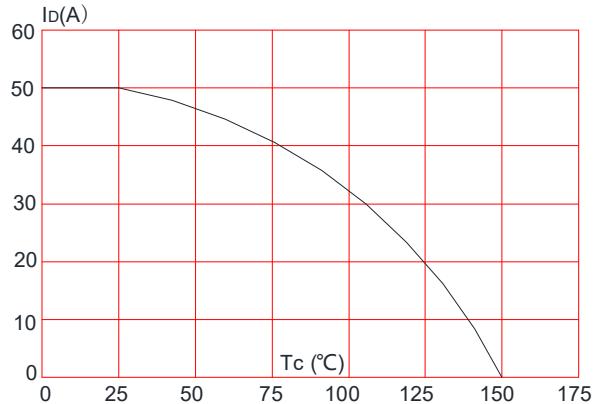
**Figure 11:** Maximum Effective Transient Thermal Impedance, Junction-to-Case



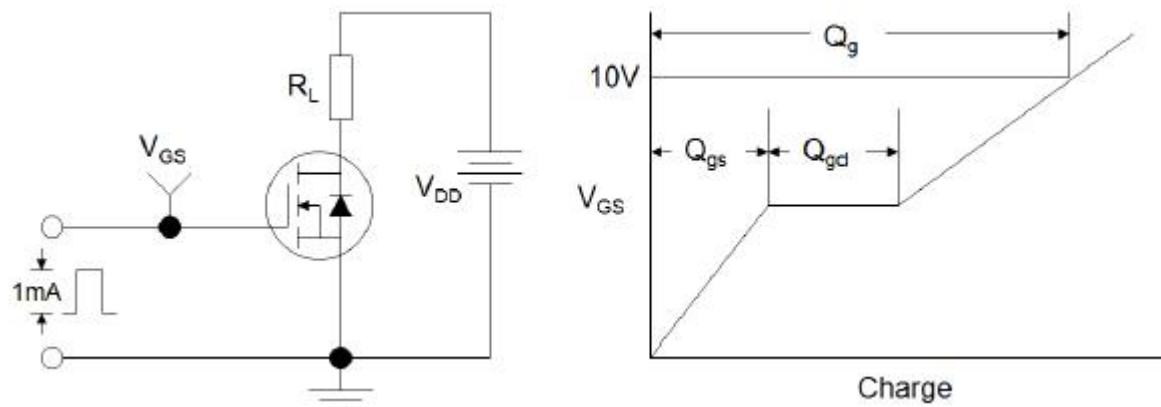
**Figure 8:** Normalized on Resistance vs. Junction Temperature



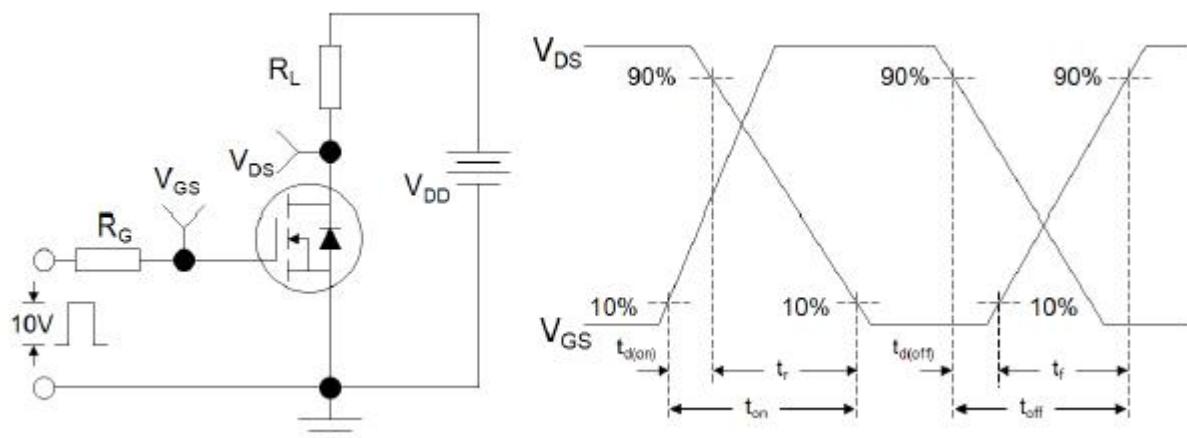
**Figure 10:** Maximum Continuous Drain Current vs. Case Temperature



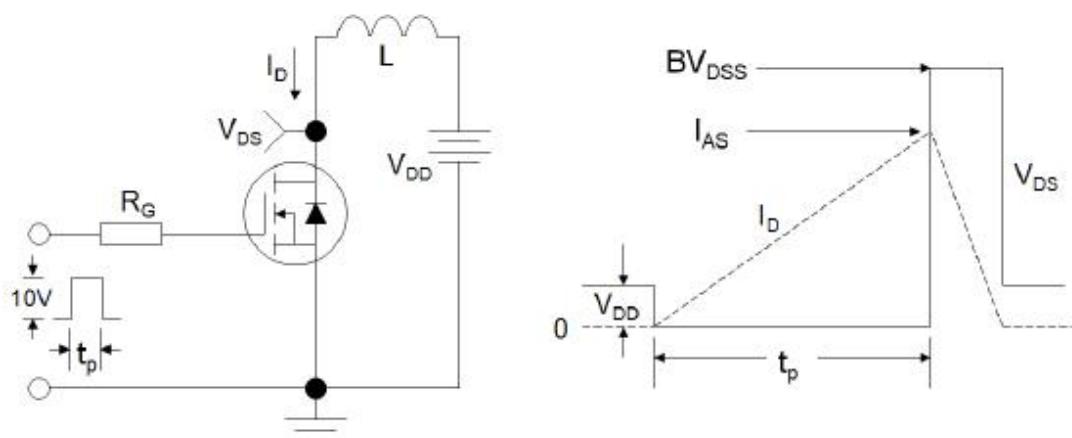
## Test Circuit



**Figure1:Gate Charge Test Circuit & Waveform**



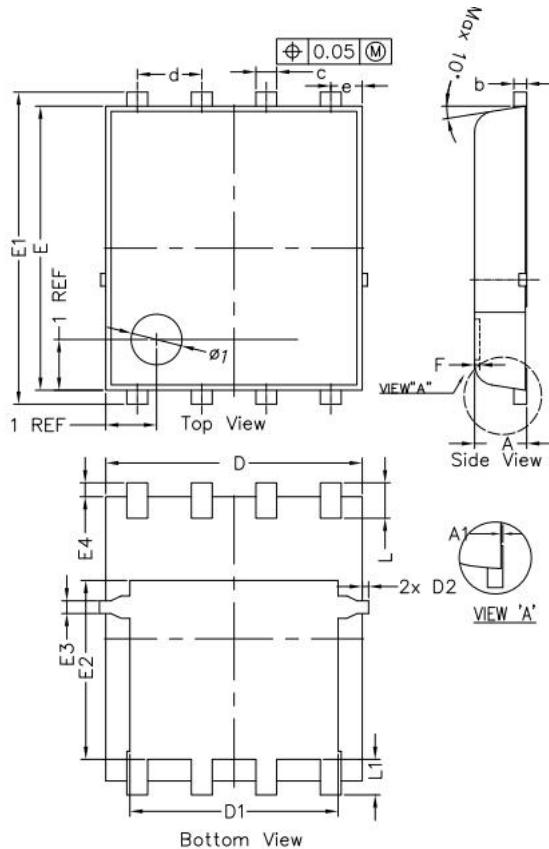
**Figure 2: Resistive Switching Test Circuit & Waveforms**



**Figure 3:Unclamped Inductive Switching Test Circuit & Waveforms**



## Package Mechanical Data- PDFN5x6-8L



| SYMBOLS | DIMENSION IN MM |       |       | DIMENSION IN INCHES |       |       |
|---------|-----------------|-------|-------|---------------------|-------|-------|
|         | MIN             | NOM   | MAX   | MIN                 | NOM   | MAX   |
| * A     | 0.900           | 1.000 | 1.100 | 0.035               | 0.039 | 0.043 |
| A1      | 0.000           | ---   | 0.050 | 0.000               | ----  | 0.002 |
| b       | 0.246           | 0.254 | 0.312 | 0.010               | 0.010 | 0.012 |
| * c     | 0.310           | 0.410 | 0.510 | 0.012               | 0.016 | 0.020 |
| d       | 1.27 BSC        |       |       | 0.050 BSC           |       |       |
| * D     | 4.950           | 5.050 | 5.150 | 0.195               | 0.199 | 0.203 |
| D1      | 4.000           | 4.100 | 4.200 | 0.157               | 0.161 | 0.165 |
| * D2    | ---             | ---   | 0.125 | ---                 | ---   | 0.005 |
| e       | 0.62 BSC        |       |       | 0.024 BSC           |       |       |
| * E     | 5.500           | 5.600 | 5.700 | 0.217               | 0.220 | 0.224 |
| * E1    | 6.050           | 6.150 | 6.250 | 0.238               | 0.242 | 0.246 |
| E2      | 3.425           | 3.525 | 3.625 | 0.135               | 0.139 | 0.143 |
| E3      | 0.150           | 0.250 | 0.350 | 0.006               | 0.010 | 0.014 |
| * E4    | 0.175           | 0.275 | 0.375 | 0.007               | 0.011 | 0.015 |
| F       | -               | -     | 0.100 | -                   | -     | 0.004 |
| * L     | 0.500           | 0.600 | 0.700 | 0.02                | 0.02  | 0.03  |
| L1      | 0.600           | 0.700 | 0.800 | 0.02                | 0.03  | 0.03  |

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